

1. In Si

- (5 pts) How many equivalent conduction band valleys are there?
- (5 pts) Where are they?

2. In Ge,

- (5 pts) How many equivalent conduction band valleys are there?
- (5 pts) Where are they?

3. In GaAs,

- (5 pts) How many equivalent conduction band valleys are there?
- (5 pts) Where are they?

4. Describe the valence band structure of semiconductors.

- (5 pts) Where does the maximum occur?
- (5 pts) Sketch the bands.

5. (10 pts) Describe the process(es) by which an electron at the valence band maximum in Si could absorb a photon equal to the bandgap. Illustrate the process(es) on a sketch of the E-k diagrams.

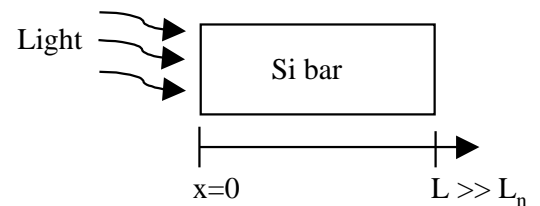
6. (10 pts) Derive the following expressions for **degenerate** statistics. You will need to use the

$$J_p = \mu_p p \vec{\nabla} F_p$$

$$J_n = \mu_n n \vec{\nabla} F_n$$

properties of the $\mathfrak{Z}(\eta)$ function described in class.

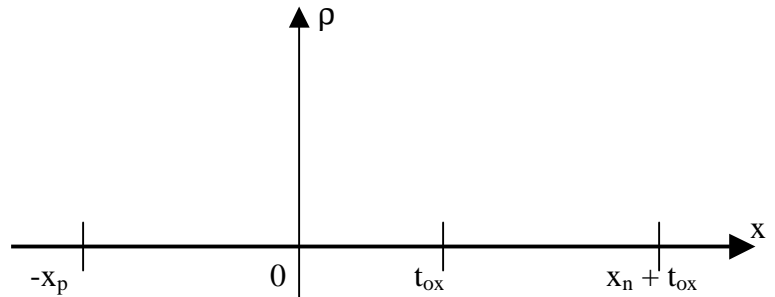
7. (10 pts) A Si bar has the following properties: $N_A = 10^{15}/\text{cm}^3$, $\mu_n = 1350 \text{ cm}^2/\text{Vs}$, $\mu_p = 500 \text{ cm}^2/\text{Vs}$, $\tau_n = \tau_p = 10^{-6} \text{ s}$. The left end of the bar is illuminated so as to create $10^{10}/\text{cm}^3$ excess electron hole pairs at $x=0$. Assuming none of the light penetrates into the interior of the bar ($x>0$), Determine the excess minority carrier profile.



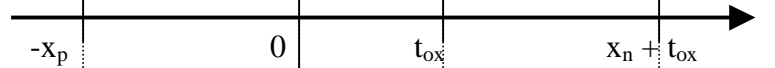
8. (10 pts) Assume that now, $L < L_n$, and, that at the right surface, the surface recombination rate is so large that $\Delta n = \Delta p = 0$. Determine the excess minority carrier profile.

9. Consider a p-type ($N_A = 10^{18} \text{ cm}^{-3}$) Si / 10 nm SiO₂ / n-type Si ($N_D = 10^{18} \text{ cm}^{-3}$) structure at 0 bias and $T=300\text{K}$, i.e. a pn junction with a 10 nm oxide between the n and p regions. Using the depletion approximation as we did for the pn diode.

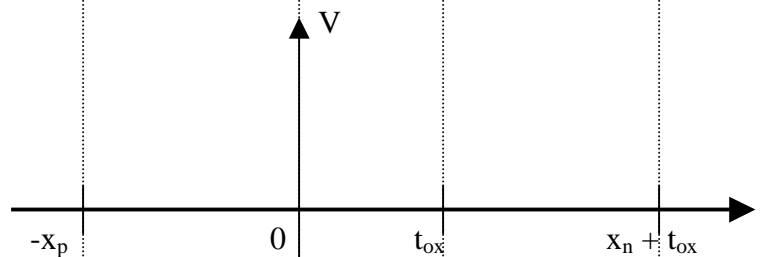
a. (10 pts) Sketch the charge distribution.
Label maximum and minimum points.



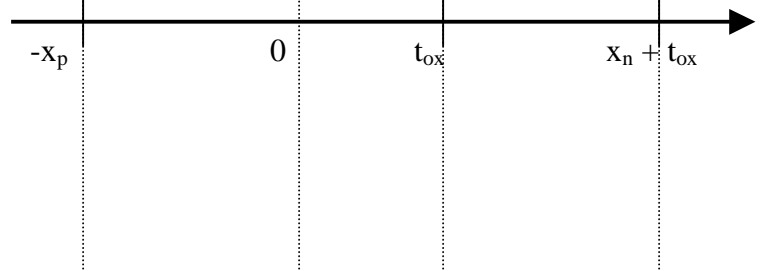
b. (10 pts) Sketch the electric field.
($\epsilon_{Si} = 11.9$ & $\epsilon_{SiO_2} = 3.9$)
Label max and min points.



c. (10 pts) Sketch the electrostatic potential.
Label max and min points.



d. (10 pts) Sketch the band diagram.
($E_G \text{ SiO}_2 = 9 \text{ eV}$. $E_c(\text{SiO}_2) - E_c(\text{Si}) = 3\text{eV}$)
(you will not be able to draw it to scale)



e. (10 pts) Calculate the built in voltage, V_{bi} . (A number in volts).

f. (50 pts) Calculate the total depletion width, $W = x_p + t_{ox} + x_n$. (a number in nm). You first have to derive the appropriate expression for W . No credit will be given for simply taking the W derived for a pn or pin junction. Pay attention to the 2 different dielectric constants.

(g) (30 pts) Calculate the capacitance in (F/cm^2).